

Application/Control	No.
10/568 947	

Examiner Hai H. Huynh Applicant(s)/Patent under Reexamination

MUTO ET AL.

Art Unit 3747

		ORIGINAL		INTERNATIONAL CLASSIFICATION											
	_ASS	AIMED				NON-0	NON-CLAIMED								
	9	F	02	D 41		/24	F	02	D	9	/00				
	CROS					,					,				
CLASS	SUBCLA	SS (ONE SU	JBCLASS PE	R BLOCK)										·	
123 346 348		348							1					1	
701	110								1					1	
								1						1	
									1					1	
									1					1	
(Assi	stant Exam	May	Hai Huynh 9/12/07					Total Claims Allowed: 14							
		(Primary Examiner) (Date)					O.G. Print Claim(s)					O.G. Print Fi			
(Legal In:						1				1					

Claims renumbered in the same order as presented by applicant											□СРА			☐ T.D.			☐ R.1.47		
Final	Original		Final	Original		Final	Original		Final	Original		Final	Original		Final	Original		Final	Original
1	1			31			61	1		91			121	1		151			181
2	2			32			62	]		92			122			152			182
3	3			33			63			93			123	l		153			183
4	4			34			64	1		94			124			154			184
5	5			35			65	1		95			125			155			185
6	6			36			66	1		96			126			156			186
7	7			37			67	1		97			127	}		157			187
8	8			38			68	1		98			128			158			188
9	9			39			69	1		99			129			159			189
10	10			40			70	1		100			130	[		160			190
11	11			41			71	1		101			131			161			191
12	12			42			72	1		102			132			162			192
13	13			43			73	1		103			133	]		163			193
14	14			44			74	1		104			134	]		164			194
	15			45			75	1		105			135	]		165			195
	16			46			76	]		106			136	]		166			196
	17	1		47	1		77	1		107			137			167			197
	18			48			78	1		108			138	1		<i>-</i> 168			198
	19			49			79	1		109			139	1		169			199
	20			50			80	1		110			140	1		170			200
	21			51			81	1		111			141			171			201
	22			52			82	1		112			142	]		172			202
	23			53			83	1		113			143			173			203
	24			54	1		84	1		114			144			174		[	204
	25			55			85	]		115			145			175			205
	26			56			86			116			146			176			206
	27			57			87			117			147			177			207
	28			58			88			118			148			178			208
	29			59			89	]		119			149	] ,		179			209
	30			60			90			120			150			180			210